## Spin transport in non-degenerate *n*-Ge

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Recently, we experimentally clarified that the donor-driven intervalley transition of electrons dominants the spin-flip scattering mechanism for heavily doped (degenerate) *n*-Ge [1,2]. It should be noted that, for degenerate *n*-Ge, the spin diffusion length is almost independent of external temperature [1] and dependent strongly on donor concentration [2] less than  $\sim 100$  K. For Ge spintronics devices, spin transport properties in non-degenerate *n*-Ge should also be explored. Here, we investigate spin transport in non-degenerate *n*-Ge by four-terminal (4T) nonlocal measurements.

We fabricated lateral spin-valve (LSV) devices with Co<sub>2</sub>FeAl<sub>0.5</sub>Si<sub>0.5</sub>/*n*-Ge Schottky-tunnel junctions to observe the spin transport. A scanning electron micrograph of a fabricated LSV device and the terminal configuration of 4T-NL measurements are shown in Fig. 1(a). Temperature-dependent resistivity and carrier concentration of the *n*-Ge spin-transport layer indicate non-degenerate semiconductor-like electrical properties [Fig. 1(b)]. When in-plane ( $B_y$ ) magnetic fields are swept, a clear NL spin signal ( $\Delta R_{\rm NL} = \Delta V_{\rm NL}/I$ ) can be observed at 8 K [inset of Fig. 1(c)]. NL Hanle-effect curves owing to the spin precession were also observed for both magnetic configurations (not shown here). To determine  $\lambda_{\rm Ge}$ , we measured  $\Delta R_{\rm NL}$  for LSV devices with various *d* [Fig. 1(c)]. From a one-dimensional spin diffusion model [3],  $\lambda_{\rm Ge}$  for non-degenerate *n*-Ge can be estimated to be ~1.66 µm, which is 2-3 times larger than those in degenerate *n*-Ge at 8 K [1,2]. Figure 1(d) shows the temperature dependence of  $\lambda_{\rm Ge}$  for non-degenerate *n*-Ge [1]. Unlike the feature for degenerate *n*-Ge [1], the value of  $\lambda_{\rm Ge}$  decreases with rising temperature even less than ~ 100 K. We will discuss the details of the spin relaxation mechanism in non-degenerate *n*-Ge.

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Figure 1 (a) SEM image of a fabricated CFAS/*n*-Ge based LSV. (b) The temperature dependence of  $\rho$  and *n* in the *n*-Ge layer. (c) *d* dependence of  $|\Delta R_{\rm NL}|$  for the LSVs with  $n \sim 7 \times 10^{17}$  cm<sup>-3</sup> at 8 K. The inset shows the NL spin signal at 8 K. (d) Temperature dependence of  $\lambda_{\rm Ge}$ , estimated from *d* dependence of NL signals.

## References

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